Search Notes					

Application/Control No.	Applicant(s)/Patent under Reexamination
09/674,079	MERIC ET AL.
Examiner	Art Unit
Hai Tran	2623

SEARCHED			
Class	Subclass	Date	Examiner
711	100,110	6/23/2006	HVT
		,	

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

	CH NOTES ARCH STRATEGY	<b>(</b> )
	DATE	EXMR
EAST text search	6/23/2006	HVT